Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/006,466	EKKEL, ERIK	
Examiner	Art Unit	
Neveen Abel-Jalil	2165	

	SEARCHED			
Class	Subclass	Date	Examiner	
Search	Updated	8/29/2005	NAJ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARC (INCLUDING SE	CH NOT	ES STRATEGY	
		DATE	EXMR
Search Updated		8/29/2005	NAJ